## DATA SHEET

MB2374
Dual octal D-type flip-flop; positive-edge trigger (3-State)

Product specification

## FEATURES

- Two 8-bit positive edge triggered registers
- Live insertion/extraction permitted
- Power-up 3-State
- Power-up reset
- Multiple $\mathrm{V}_{\mathrm{CC}}$ and $G N D$ pins minimize switching noise
- 3-State output buffers
- Output capability: +64mA/-32mA
- Latch-up protection exceeds 500mA per Jedec Std 17
- ESD protection exceeds 2000V per MIL STD 883 Method 3015 and 200V per Machine Model


## DESCRIPTION

The MB2374 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The MB2374 has two 8-bit, edge triggered registers, with each register coupled to eight 3 -State output buffers. The two sections of each register are controlled independently by the clock (nCP) and Output Enable ( nOE ) control gates.

Each register is fully edge triggered. The state of each $D$ input, one set-up time before the Low-to-High clock transition, is transferred to the corresponding flip-flop's Q output.

The 3-State output buffers are designed to drive heavily loaded 3-State buses, MOS memories, or MOS microprocessors. Each active-Low Output Enable (n $\overline{O E}$ ) controls all eight 3-State buffers for its register independent of the clock operation.

When $\mathrm{n} \overline{\mathrm{OE}}$ is Low, the stored data appears at the outputs for that register. When nOE is High, the outputs for that register are in the High-impedance "OFF" state, which means they will neither drive nor load the bus.

## QUICK REFERENCE DATA

| SYMBOL | PARAMETER | $\begin{gathered} \text { CONDITIONS } \\ \mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C} ; \text { GND }=0 \mathrm{~V} \end{gathered}$ | TYPICAL | UNIT |
| :---: | :---: | :---: | :---: | :---: |
| $\begin{aligned} & \hline t_{\text {PLH }} \\ & t_{\mathrm{PHL}} \end{aligned}$ | Propagation delay nCP to nQx | $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF} ; \mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ | $\begin{aligned} & 3.4 \\ & 3.6 \end{aligned}$ | ns |
| $\mathrm{C}_{\text {IN }}$ | Input capacitance | $\mathrm{V}_{\mathrm{I}}=0 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}$ | 4 | pF |
| Cout | Output capacitance | $\mathrm{V}_{\mathrm{O}}=0 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}} ; 3$-State | 7 | pF |
| ICCZ | Total supply current | Outputs disabled; $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$ | 120 | $\mu \mathrm{A}$ |

## ORDERING INFORMATION

| PACKAGES | TEMPERATURE RANGE | OUTSIDE NORTH AMERICA | NORTH AMERICA | DWG NUMBER |
| :---: | :---: | :---: | :---: | :---: |
| $52-$ pin plastic Quad Flat Pack | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | MB2374 BB | MB2374 BB | SOT379-1 |

## PIN CONFIGURATION



## PIN DESCRIPTION

| PIN NUMBER | SYMBOL | FUNCTION |
| :---: | :---: | :---: |
| $\begin{aligned} & 44,43,41,40, \\ & 38,37,35,34, \\ & 32,31,29,28, \\ & 26,25,23,22 \end{aligned}$ | $\begin{aligned} & 1 \mathrm{DO} 0-1 \mathrm{D7} \\ & 2 \mathrm{D} 0-2 \mathrm{D} 7 \end{aligned}$ | Data inputs |
| $\begin{gathered} 48,49,51,52, \\ 2,3,5,6, \\ 8,9,11,12, \\ 14,15,17,18 \end{gathered}$ | $\begin{aligned} & 1 Q 0-1 Q 7 \\ & 2 Q 0-2 Q 7 \end{aligned}$ | Data outputs |
| 47, 19 | 1OE, 2OE | Output enable inputs (active-Low) |
| 45, 21 | 1CP, 2CP | Clock pulse inputs (active rising edge) |
| $\begin{gathered} 4,7,10,16,20,24 \\ 30,33,36,42,46,50 \end{gathered}$ | GND | Ground (0V) |
| 1, 13, 27, 39 | $\mathrm{V}_{\mathrm{CC}}$ | Positive supply voltage |

16-bit D-type flip-flop; positive-edge trigger (3-State)

LOGIC SYMBOL


LOGIC SYMBOL (IEEE/IEC)


## LOGIC DIAGRAM



## FUNCTION TABLE

| INPUTS |  |  | INTERNAL REGISTER | OUTPUTS | OPERATING MODE |
| :---: | :---: | :---: | :---: | :---: | :---: |
| nOE | nCP | nDx |  | nQ0 - nQ7 |  |
| $\begin{aligned} & \mathrm{L} \\ & \mathrm{~L} \end{aligned}$ | $\uparrow$ | $\begin{aligned} & \text { I } \\ & \text { h } \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{H} \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{H} \end{aligned}$ | Load and read register |
| L | $\uparrow$ | X | NC | NC | Hold |
| $\begin{aligned} & \mathrm{H} \\ & \mathrm{H} \end{aligned}$ | $\uparrow$ | $\begin{gathered} \mathrm{X} \\ \mathrm{nDx} \end{gathered}$ | $\begin{aligned} & \mathrm{NC} \\ & \mathrm{nDx} \end{aligned}$ | $\begin{aligned} & \mathrm{z} \\ & \mathrm{z} \end{aligned}$ | Disable outputs |

$H=$ High voltage level
h = High voltage level one set-up time prior to the High-to-Low E transition
$\mathrm{L}=$ Low voltage level
। = Low voltage level one set-up time prior to the High-to-Low E transition
$\mathrm{NC}=$ No change
X = Don't care
Z = High impedance "off" state
$\uparrow=$ Low-to-High clock transition
$\uparrow=$ Not a Low-to-High clock transition

## ABSOLUTE MAXIMUM RATINGS ${ }^{1,2}$

| SYMBOL | PARAMETER | CONDITIONS | RATING | UNIT |
| :---: | :--- | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | DC supply voltage | -0.5 to +7.0 | V |  |
| $\mathrm{I}_{\mathrm{IK}}$ | DC input diode current |  | -18 | mA |
| $\mathrm{~V}_{\mathrm{I}}$ | DC input voltage ${ }^{3}$ |  | -1.2 to +7.0 | V |
| $\mathrm{I}_{\mathrm{OK}}$ | DC output diode current | $\mathrm{V}_{\mathrm{O}}<0$ | -50 | mA |
| $\mathrm{~V}_{\text {OUT }}$ | DC output voltage ${ }^{3}$ | output in Off or High state | -0.5 to +5.5 | V |
| $\mathrm{I}_{\text {OUT }}$ | DC output current | output in Low state | 128 | mA |
| $\mathrm{~T}_{\text {stg }}$ | Storage temperature range |  | -65 to 150 | ${ }^{\circ} \mathrm{C}$ |

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
2. The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed $150^{\circ} \mathrm{C}$.
3. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

## RECOMMENDED OPERATING CONDITIONS

| SYMBOL | PARAMETER | LIMITS |  | UNIT |
| :---: | :--- | :---: | :---: | :---: |
|  |  | MIN | MAX |  |
| $\mathrm{V}_{\mathrm{CC}}$ | DC supply voltage | 4.5 | 5.5 | V |
| $\mathrm{~V}_{\mathrm{I}}$ | Input voltage | 0 | $\mathrm{~V}_{\mathrm{CC}}$ | V |
| $\mathrm{V}_{\mathrm{IH}}$ | High-level input voltage | 2.0 |  | V |
| $\mathrm{~V}_{\mathrm{IL}}$ | Low-level Input voltage |  | 0.8 | V |
| $\mathrm{I}_{\mathrm{OH}}$ | High-level output current |  | -32 | mA |
| $\mathrm{I}_{\mathrm{OL}}$ | Low-level output current |  | 64 | mA |
| $\Delta \mathrm{t} / \Delta \mathrm{V}$ | Input transition rise or fall rate | 0 | 10 | $\mathrm{~ns} / \mathrm{V}$ |
| $\mathrm{T}_{\mathrm{amb}}$ | Operating free-air temperature range | -40 | +85 | ${ }^{\circ} \mathrm{C}$ |

## DC ELECTRICAL CHARACTERISTICS

| SYMBOL | PARAMETER | TEST CONDITIONS | LIMITS |  |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\mathrm{T}_{\text {amb }}=+25^{\circ} \mathrm{C}$ |  |  | $\begin{gathered} \mathrm{T}_{\mathrm{amb}}=-40^{\circ} \mathrm{C} \\ \text { to }+85^{\circ} \mathrm{C} \end{gathered}$ |  |  |
|  |  |  | MIN | TYP | MAX | MIN | MAX |  |
| $\mathrm{V}_{\text {IK }}$ | Input clamp voltage | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} ; \mathrm{l}_{\mathrm{IK}}=-18 \mathrm{~mA}$ |  | -0.9 | -1.2 |  | -1.2 | V |
| $\mathrm{V}_{\mathrm{OH}}$ | High-level output voltage | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} ; \mathrm{I}_{\mathrm{OH}}=-3 \mathrm{~mA} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{IL}}$ or $\mathrm{V}_{\mathrm{IH}}$ | 2.5 | 2.9 |  | 2.5 |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=5.0 \mathrm{~V} ; \mathrm{I}_{\mathrm{OH}}=-3 \mathrm{~mA} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{IL}}$ or $\mathrm{V}_{\mathrm{IH}}$ | 3.0 | 3.4 |  | 3.0 |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} ; \mathrm{l}_{\mathrm{OH}}=-32 \mathrm{~mA} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\text {IL }}$ or $\mathrm{V}_{\mathrm{IH}}$ | 2.0 | 2.4 |  | 2.0 |  | V |
| $\mathrm{V}_{\text {OL }}$ | Low-level output voltage | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$; $\mathrm{l}_{\mathrm{OL}}=64 \mathrm{~mA} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{IL}}$ or $\mathrm{V}_{\text {IH }}$ |  | 0.42 | 0.55 |  | 0.55 | V |
| $\mathrm{V}_{\text {RST }}$ | Power-up output voltage ${ }^{3}$ | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V} ; \mathrm{I}_{\mathrm{O}}=1 \mathrm{~mA} ; \mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ or $\mathrm{V}_{\mathrm{CC}}$ |  | 0.13 | 0.55 |  | 0.55 | V |
| 1 | Input leakage current | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ or 5.5 V |  | $\pm 0.01$ | $\pm 1.0$ |  | $\pm 1.0$ | $\mu \mathrm{A}$ |
| IOFF | Power-off leakage current | $\mathrm{V}_{\mathrm{CC}}=0.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}$ or $\mathrm{V}_{1} \leq 4.5 \mathrm{~V}$ |  | $\pm 5.0$ | $\pm 100$ |  | $\pm 100$ | $\mu \mathrm{A}$ |
| IPU/PD | Power-up/down 3-State output current ${ }^{4}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=2.1 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}=0.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{GND} \text { or } \mathrm{V}_{\mathrm{CC}}, \\ & \mathrm{~V}_{\mathrm{OE}}=\mathrm{GND} \end{aligned}$ |  | $\pm 5.0$ | $\pm 50$ |  | $\pm 50$ | $\mu \mathrm{A}$ |
| $\mathrm{l}_{\text {OzH }}$ | 3-State output High current | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}=2.7 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{IL}}$ or $\mathrm{V}_{\mathrm{IH}}$ |  | 5.0 | 50 |  | 50 | $\mu \mathrm{A}$ |
| lozl | 3-State output Low current | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}=0.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{IL}}$ or $\mathrm{V}_{\mathrm{IH}}$ |  | -5.0 | -50 |  | -50 | $\mu \mathrm{A}$ |
| $I_{\text {CEX }}$ | Output High leakage current | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}=5.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ or $\mathrm{V}_{\mathrm{CC}}$ |  | 5.0 | 50 |  | 50 | $\mu \mathrm{A}$ |
| Io | Output current ${ }^{1}$ | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}=2.5 \mathrm{~V}$ | -50 | -70 | -180 | -50 | -180 | mA |
| $\mathrm{I}_{\mathrm{CCH}}$ | Quiescent supply current | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$; Outputs High, $\mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ or $\mathrm{V}_{\mathrm{CC}}$ |  | 120 | 250 |  | 250 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{CCL}}$ |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$; Outputs Low, $\mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ or $\mathrm{V}_{\mathrm{CC}}$ |  | 48 | 60 |  | 60 | mA |
| ICCz |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$; Outputs 3-State; <br> $V_{1}=G N D$ or $V_{C C}$ |  | 120 | 250 |  | 250 | $\mu \mathrm{A}$ |
| $\Delta_{\text {cc }}$ | Additional supply current per input pin ${ }^{2}$ | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$; one input at 3.4 V , other inputs at $\mathrm{V}_{\mathrm{CC}}$ or GND |  | 0.5 | 1.5 |  | 1.5 | mA |

## NOTES:

1. Not more than one output should be tested at a time, and the duration of the test should not exceed one second.
2. This is the increase in supply current for each input at 3.4 V .
3. For valid test results, data must not be loaded into the flip-flops (or latches) after applying the power.
4. This parameter is valid for any $V_{C C}$ between 0 V and 2.1 V with a transition time of up to 10 msec . From $\mathrm{V}_{\mathrm{CC}}=2.1 \mathrm{~V}$ to $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V} \pm 10 \% \mathrm{a}$ transition time of up to $100 \mu \mathrm{sec}$ is permitted.

## AC CHARACTERISTICS

$\mathrm{GND}=0 \mathrm{~V}, \mathrm{t}_{\mathrm{R}}=\mathrm{t}_{\mathrm{F}}=2.5 \mathrm{~ns}, \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=500 \Omega$

| SYMBOL | PARAMETER | WAVEFORM | LIMITS |  |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\begin{gathered} \mathrm{T}_{\mathrm{amb}}=+25^{\circ} \mathrm{C} \\ \mathrm{~V}_{\mathrm{cc}}=+5.0 \mathrm{~V} \end{gathered}$ |  |  | $\begin{gathered} \mathrm{T}_{\mathrm{amb}}=-40 \text { to } \\ +85^{\circ} \mathrm{C} \\ \mathrm{~V}_{\mathrm{CC}}=+5.0 \mathrm{~V} \pm 0.5 \mathrm{~V} \end{gathered}$ |  |  |
|  |  |  | MIN | TYP | MAX | MIN | MAX |  |
| $\mathrm{f}_{\text {MAX }}$ | Maximum clock frequency | 1 | 180 | 260 |  | 180 |  | MHz |
| $\begin{aligned} & \text { tpLH } \\ & t_{\text {PHL }} \end{aligned}$ | Propagation delay nCP to nQx | 1 | $\begin{aligned} & 1.8 \\ & 1.8 \end{aligned}$ | $\begin{aligned} & 3.4 \\ & 3.6 \end{aligned}$ | $\begin{aligned} & 4.6 \\ & 4.6 \end{aligned}$ | $\begin{aligned} & 1.8 \\ & 1.8 \end{aligned}$ | $\begin{aligned} & 5.1 \\ & 5.1 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpzH } \\ & \text { tpZL } \\ & \hline \end{aligned}$ | Output enable time to High and Low level | $\begin{aligned} & 3 \\ & 4 \\ & \hline \end{aligned}$ | $\begin{aligned} & 1.2 \\ & 2.1 \\ & \hline \end{aligned}$ | $\begin{aligned} & 3.0 \\ & 4.0 \\ & \hline \end{aligned}$ | $\begin{aligned} & 4.1 \\ & 5.5 \\ & \hline \end{aligned}$ | $\begin{aligned} & 1.2 \\ & 2.1 \end{aligned}$ | $\begin{aligned} & 4.8 \\ & 6.2 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpHZ } \\ & \mathrm{t}_{\mathrm{PLLZ}} \end{aligned}$ | Output disable time from High and Low level | $\begin{aligned} & 3 \\ & 4 \end{aligned}$ | $\begin{aligned} & 1.2 \\ & 1.8 \end{aligned}$ | $\begin{aligned} & 3.4 \\ & 3.6 \end{aligned}$ | $\begin{aligned} & 4.6 \\ & 5.0 \end{aligned}$ | $\begin{aligned} & 1.2 \\ & 1.8 \end{aligned}$ | $\begin{aligned} & 5.1 \\ & 5.5 \end{aligned}$ | ns |

## AC SETUP REQUIREMENTS

$\mathrm{GND}=0 \mathrm{~V}, \mathrm{t}_{\mathrm{R}}=\mathrm{t}_{\mathrm{F}}=2.5 \mathrm{~ns}, \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=500 \Omega$

| SYMBOL | PARAMETER | WAVEFORM | LIMITS |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\begin{gathered} \mathrm{T}_{\mathrm{amb}}=+25^{\circ} \mathrm{C} \\ \mathrm{~V}_{\mathrm{CC}}=+5.0 \mathrm{~V} \end{gathered}$ |  | $\begin{gathered} \mathrm{T}_{\mathrm{amb}}=-40 \text { to }+85^{\circ} \mathrm{C} \\ \mathrm{~V}_{\mathrm{CC}}=+5.0 \mathrm{~V} \pm 0.5 \mathrm{~V} \end{gathered}$ |  |
|  |  |  | MIN | TYP | MIN |  |
| $\begin{aligned} & \mathrm{t}_{\mathrm{s}}(\mathrm{H}) \\ & \mathrm{t}_{\mathrm{s}}(\mathrm{~L}) \\ & \hline \end{aligned}$ | Setup time, High or Low nDx to nCP | 2 | $\begin{aligned} & 1.0 \\ & 1.0 \end{aligned}$ | $\begin{aligned} & 0.3 \\ & 0.1 \end{aligned}$ | $\begin{aligned} & 1.0 \\ & 1.0 \end{aligned}$ | ns |
| $\begin{aligned} & \mathrm{t}_{\mathrm{h}}(\mathrm{H}) \\ & \mathrm{t}_{\mathrm{h}}(\mathrm{~L}) \end{aligned}$ | Hold time, High or Low nDx to nCP | 2 | $\begin{aligned} & 1.0 \\ & 1.0 \end{aligned}$ | $\begin{aligned} & -0.1 \\ & -0.3 \end{aligned}$ | $\begin{aligned} & 1.0 \\ & 1.0 \end{aligned}$ | ns |
| ( ${ }_{\text {tw }}(\mathrm{H})$ | nCP pulse width High or Low | 1 | $\begin{aligned} & 2.8 \\ & 2.8 \end{aligned}$ | $\begin{aligned} & 1.2 \\ & 1.5 \end{aligned}$ | $\begin{aligned} & 2.8 \\ & 2.8 \\ & \hline \end{aligned}$ | ns |

## AC WAVEFORMS

$\mathrm{V}_{\mathrm{M}}=1.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN}}=\mathrm{GND}$ to 3.0 V


Waveform 1. Propagation Delay, Clock Input to Output, Clock Pulse Width, and Maximum Clock Frequency


NOTE: The shaded areas indicate when the input is permitted to change for predictable output performance.


Waveform 3. 3-State Output Enable Time to High Level and Output Disable Time from High Level


Waveform 4. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level

Waveform 2. Data Setup and Hold Times

16-bit D-type flip-flop; positive-edge trigger (3-State)

## TEST CIRCUIT AND WAVEFORM





## 16-bit D-type flip-flop; positive-edge trigger (3-State)






Adjustment of $\mathrm{t}_{\text {THL }}$ for



detail $X$


DIMENSIONS (mm are the original dimensions)

| UNIT | $\mathbf{A}$ <br> $\mathbf{m a x}^{2}$ | $\mathbf{A}_{\mathbf{1}}$ | $\mathbf{A}_{\mathbf{2}}$ | $\mathbf{A}_{\mathbf{3}}$ | $\mathbf{b}_{\mathbf{p}}$ | $\mathbf{c}$ | $\mathbf{D}^{(1)}$ | $\mathbf{E}^{(1)}$ | $\mathbf{e}$ | $\mathbf{H}_{\mathbf{D}}$ | $\mathbf{H}_{\mathbf{E}}$ | $\mathbf{L}$ | $\mathbf{L}_{\mathbf{p}}$ | $\mathbf{v}$ | $\mathbf{w}$ | $\mathbf{y}$ | $\mathbf{Z}_{\mathbf{D}}^{(1)}$ | $\mathbf{Z}_{\mathbf{E}} \mathbf{( 1 )}^{(1)}$ | $\boldsymbol{\theta}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| mm | 2.45 | 0.45 | 2.10 | 0.25 | 0.38 | 0.23 | 10.1 | 10.1 | 0.65 | 13.45 | 13.45 | 1.60 | 0.95 | 0.20 | 0.12 | 0.10 | 1.24 | 1.24 | $7^{0}$ |
| 0.25 | 1.95 | 0.25 | 0.22 | 0.13 | 9.9 | 9.9 | 0.6 | 12.95 | 12.95 | 1.60 | 0.65 | 0.95 | 0.95 | $0^{0}$ |  |  |  |  |  |

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

| OUTLINE VERSION | REFERENCES |  |  | EUROPEAN PROJECTION | ISSUE DATE |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | IEC | JEDEC | EIAJ |  |  |
| SOT379-1 |  | MO-108 |  |  | $\begin{aligned} & -95-02-04 \\ & 97-08-04 \end{aligned}$ |

## Data sheet status

| Data sheet <br> status | Product <br> status | Definition [1] |
| :--- | :--- | :--- |
| Objective <br> specification | Development | This data sheet contains the design target or goal specifications for product development. <br> Specification may change in any manner without notice. |
| Preliminary <br> specification | Qualification | This data sheet contains preliminary data, and supplementary data will be published at a later date. <br> Philips Semiconductors reserves the right to make chages at any time without notice in order to <br> improve design and supply the best possible product. |
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

## Definitions

Short-form specification - The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.
Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.
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